

Dual N-Channel Enhancement Mode Field Effect Transistor with ESD Protection

Description

The ACE8202B uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. They offer operation over a wide gate drive range from 2.5V to 12V. It is ESD protected. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration.

Features

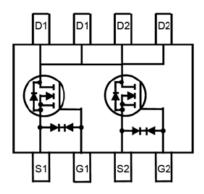
- V_{DS}(V)=20V
- I_D=7.5A (V_{GS}=4.5V)
- R_{DS(ON)}<21 mΩ (V_{GS}=4.5V)
- $R_{DS(ON)} < 35 \text{ m}\Omega (V_{GS} = 2.5 \text{V})$
- ESD Protected: 2000V

Absolute Maximum Ratings

| Parameter | | | Мах | Unit |
|--|------------------------------------|------------------|---------|------|
| Drain-Source Voltage | | | 20 | V |
| Gate-Source Voltage | V_{GSS} | ±12 | V | |
| Continuous Drain Current *AC | T _A =25℃ | · I _D | 7.5 | A |
| | T _A =70 ℃ | ۱D | 6 | |
| Pulsed Drain Current | | | 25 | А |
| Power Dissipation | T _A =25℃ | р | 2.5 | w |
| Power Dissipation | T _A =70°C | P _D | 1.6 | |
| Operating Junction Temperature / Storage Temperature Range | | T_J/T_{STG} | -55/150 | °C |

Packaging Type

DFN3*3-8L

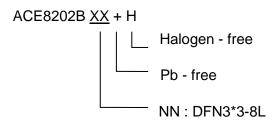




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Ordering information



Electrical Characteristics

 $T_A\!\!=\!\!25^\circ\!\!\mathbb{C}$, unless otherwise noted.

| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit |
|--|----------------------|--|------|------|------|------|
| | | Static | | | | |
| Drain-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} =0V, I _D =250 uA | 20 | | | V |
| Gate Threshold Voltage | V _{GS(th)} | $V_{DS}=V_{GS}$, $I_{DS}=250$ uA | 0.4 | 0.65 | 1 | |
| Gate Leakage Current | I _{GSS} | $V_{DS}=0V, V_{GS}=\pm 12V$ | | 6.5 | 10 | uA |
| Zero Gate Voltage Drain Current | I _{DSS} | V_{DS} =20V, V_{GS} =0V | | | 1 | uA |
| Maximum Body-Diode Continuous Current | I _S | | | | 2.5 | А |
| Drain-Source On-Resistance | R _{DS(ON)} | V _{GS} =4.5V, I _D =8A | | 15.7 | 21 | mΩ |
| | | V _{GS} =2.5V, I _D =7A | | 26 | 35 | |
| Forward Transconductance | gfs | V _{DS} =5V,I _D =7A | | 34 | | S |
| Diode Forward Voltage | V_{SD} | I _{SD} =2.5A, V _{GS} =0V | | 0.77 | 1 | V |
| | | Switching | | | | |
| Total Gate Charge | Qg | V _{DS} =10V, V _{GS} =4.5V, I _D =7A | | 11 | | nC |
| Gate-Source Charge | Q_{gs} | | | 2 | | |
| Gate-Drain Charge | Q_gd | | | 3.2 | | |
| Turn-On Time | td(on) | V _{GS} =5V, R _L =2.5Ω, V _{DS} =10V, R _{GEN} =3Ω | | 300 | | nS |
| | tr | | | 600 | | |
| Turn-Off Time | td(off) | | | 790 | | |
| | tf | | | 440 | | |
| | | Dynamic | | | | |
| Input Capacitance | Ciss | V _{GS} =0V, V _{DS} =10V, f=1MHz | | 920 | | pF |
| Output Capacitance | Coss | | | 155 | | |
| REVERSE Transfer Capacitance | Crss | | | 75 | | |

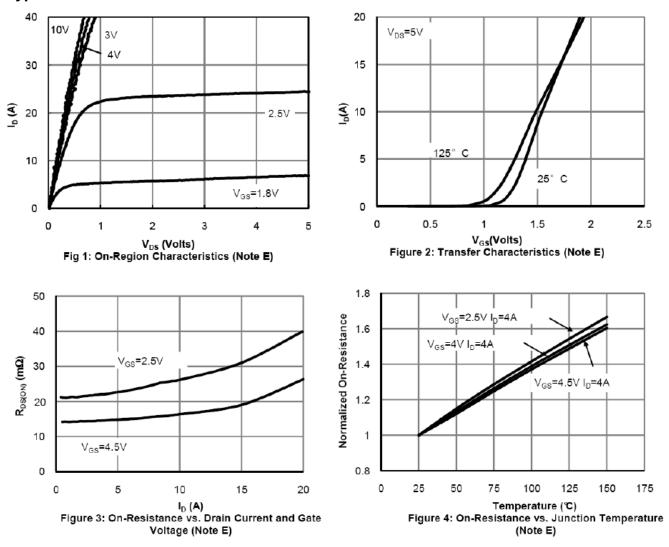


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Note:

- 1. The value of R θ JA is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t \leq 10s thermal resistance rating.
- 2. Repetitive rating, pulse width limited by junction temperature.
- 3. The R θ JA is the sum of the thermal impedence from junction to lead R θ JL and lead to ambient .
- 4. The static characteristics are obtained using <300 μs pulses, duty cycle 0.5% max.
- 5. These tests are performed with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.



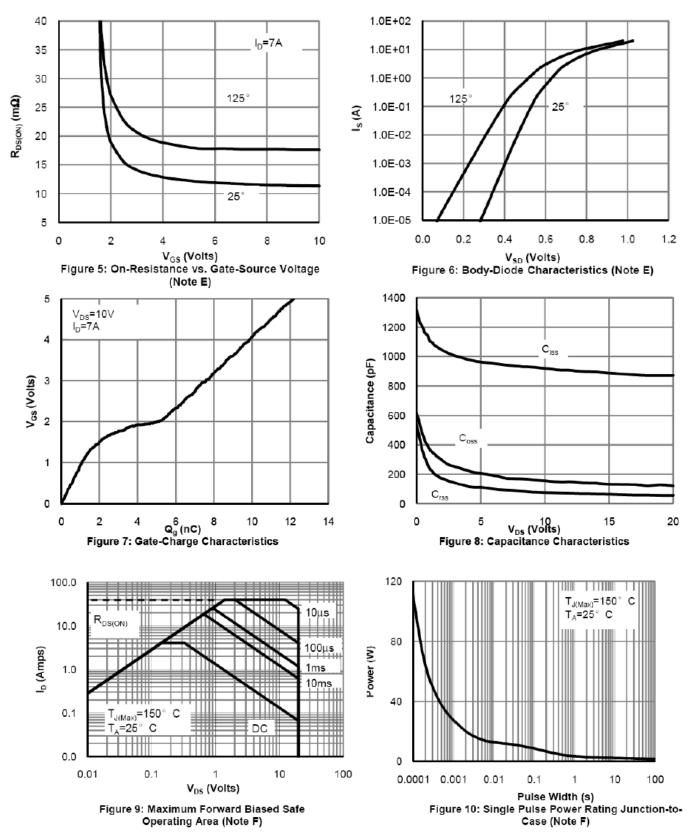
Typical Performance Characteristics



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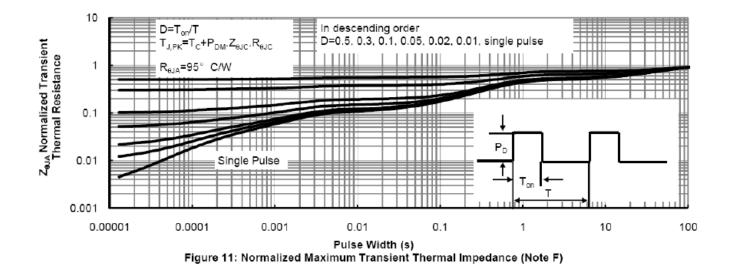




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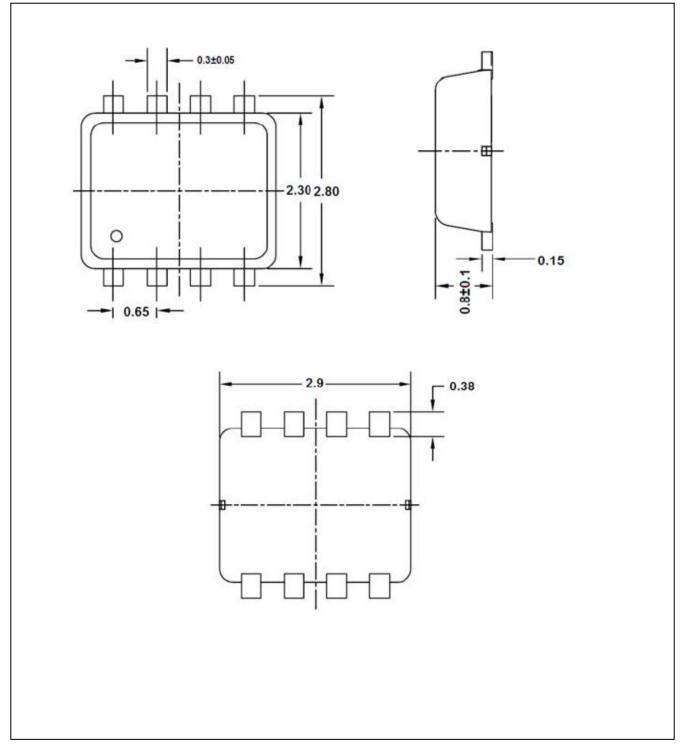


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Packing Information

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Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Electronics Co., LTD. As sued herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and shoes failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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